

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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*	C	US-6,367,036	04-2002	Hansen, Ole Brian	711/135
*	D	US-6,219,827	04-2001	Man, Richard F.	711/135
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*	U	Bell et al.; Optimally Profiling and Tracing Programs; Jul. 1994; pp 1319-1360.
*	V	International Business Machines; Adaptive Trace-Directed Program Restructuring; Feb. 1994; pp. 115-116; IBM Technical Disclosure Bulletin; vol. 37, No. 02B.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.